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LIST OF PATENTS AND PUBLICATIONS FOR **APPLICANT'S INFORMATION DISCLOSURE STATEMENT** 

(use several sheets if necessary)

SERIAL NO. CASE NO. 10/660,165

**FILING DATE** 

**GROUP ART UNIT** 

9281-4636

September 10, 2003

7653

APPLICANT(S): Hisayuki Yazawa et al.

## REFERENCE DESIGNATION

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APPLICANT'S INFORMATION DISCLOSURE

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APPLICANTS: Hisayuki Yazawa et al.

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